



# 47 CFR PART 15B

# **TEST REPORT**

Issued to

Qingdao Haier Telecom Co.,ltd. No.1 Haier Road Hi-tech Zone Qingdao P.R.CHINA

For

CDMA 1x mobile phone

Model Name:

HC-C53

Brand Name:

Haier

FCC ID:

SG70121HC-C53

Test Rule:

47 CFR Part 2

47 CFR Part 15 Subpart B

Test date:

February 27, 2011 - March 9, 2011

Shenzhen Morlab Communications Technology Co., Ltd.

Tested by Tian Junjie

Date

2011.3.10

Certificati

Date



**IEEE 1725** 









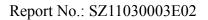






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	Issue	Date	Reason for change		
	1.0	September 20, 2010	First edition		



#### 1. General Information

# 1.1 Equipment under Test (EUT) Description

Serial No. ..... (n.a, marked #1 by test site)

Hardware Version ...... P0V0

Modulation ...... CDMA 1X Emission Designator : 1M25F9W

Frequency ...... Tx: 1851.25 MHz -1908.75 MHz; Rx: 1931.25 MHz-1988.75 MHz

Manufacturer ...... Qingdao Haier Telecom Co.,ltd

No.1 Haier Road Hi-tech Zone Qingdao P.R.CHINA

Power Supply: ..... Battery

Model Name: 423450A Brand name: BAK Capacitance: 800mAh Rated voltage: 3.7V

Manufacturer: ShenZhen BAK Battery CO.,LTD

Manufacturer Address: BAK Industrial Park, Kuichong

Street, Longgang District, Shenzhen

Accessory Equipment:..... AC Adapter (Charger for Battery)

Model Name: H21115 Brand Name: 利顺达

Serial No.: (n.a. marked #1 by test site)
Rated Input: ~ 100-240V, 50-60Hz, 150mA

Rated Output: = 5.0V, 550mA

Manufacturer: Ningbo Lishunda Electronics Co.,Ltd

Manufacturer Address: No.13 Lishan Guangming Rd. Yuyao City,

Ningbo, Zhejiang, China

## NOTE:

1. The EUT is a model of CDMA 1X mobile station operating in 1900 band.

- 2. The normal configuration for the EUT is the Mobile Phone (MS) associated with ancillary equipments e.g. the Battery and/or the AC Adapter (Charger).
- 3. For detailed features about the EUT, please see user manual supplied by the applicant.



# 1.2 Test Standards and Results

The objective of the report is to perform tests according to 47 CFR Part 2, Part 15 for FCC ID Certification:

No.	Identity	Document Title
1	47 CFR Part 2	Frequency Allocations and Radio Treaty Matters; General Rules and
	(10-1-09 Edition)	Regulations
2	47 CFR Part 15	Radio Frequency Devices
	(10-1-09 Edition)	

Test detailed items and the results are as below:

No.	Rules	Test Type	Result
FCC	FCC Part 15 Requirement		
1	§15.107	Conducted Emissions	PASS
2	§15.109	Radiated Emissions	PASS

## NOTE:

The tests were performed according to the method of measurements prescribed in ANSI C63.4 2003.



## 1.3 Facilities and Accreditations

#### 1.3.1 Facilities

Shenzhen Morlab Communications Technology Co., Ltd. Morlab Laboratory is a testing organization accredited by China National Accreditation Service for Conformity Assessment (CNAS) according to ISO/IEC 17025. The accreditation certificate number is L3572..

All measurement facilities used to collect the measurement data are located at 3/F, Electronic Testing Building, Shahe Road, Xili, Nanshan District, Shenzhen, 518055 P. R. China. The site was constructed in conformance with the requirements of ANSI C63.7, ANSI C63.4 and CISPR Publication 22, the FCC registration number is 741109.

# 1.3.2 Test Equipments

No.	Description	Specification		Cal. date
1	System Simulator	Manufacturer:	Rohde&Schwarz	2010.09
		Model No.:	CMU200	
		Serial No.:	100448	
2	System Simulator	Manufacturer:	Agilent	2010.09
		Model No.:	E5515C	
		Serial No.:	GB43130131	
3	Spectrum Analyzer	Manufacturer:	Agilent	2010.09
		Model No.:	E7405A	
		Serial No.:	US44210471	
4	Telecommunication	Manufacturer:	European Antennas	2010.09
	Antenna	Model No.:	PSA-45010R/356	
		Serial No.:	403688-001	
5	Trilogy Antenna	Manufacturer:	Schwarzbeck	2010.09
		Model No.:	VULB 9163	
		Serial No.:	9163-274	
6	Horn Antenna	Manufacturer:	Schwarzbeck	2010.09
		Model No.:	BBHA 9120C	
		Serial No.:	9120C-384	
7	Power Splitter	Manufacturer:	WEINSCHEL	2010.09
		Model No.:	1506A	
		Serial No.:	NW521	
8	Anechoic Chamber	Manufacturer:	Albatross Projects GmbH	2010.09
9	DC Power Supply	Manufacturer:	Good Will Instrument Co.,	2010.09
		Ltd.		
10	Temperature Chamber	Manufacturer:	Chongqing YinHe	2010.09



No.	Description	Specification	Cal. date
		Experimental Equip. Co., Ltd.	

# NOTE:

1. Equipments listed above have been calibrated and are in the period of validation.

# 1.3.3 Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature:	20 - 25°C
Relative Humidity:	40 - 60%
Atmospheric Pressure:	86-106kPa



# 2. 47 CFR Part 15B Requirements

## 2.1 General Information

#### **2.1.1 Test Mode**

The test modes of the EUT are showed as below:

#### (1) Call Mode:

The EUT configuration of the emission tests was MS + Battery + Charger + Headset.

Before the measurement, the lithium battery was completely discharge.

During the measurement, the lithium battery was installed into the MS, and the charger was connected to the MS. A communication link was established between the MS and a System Simulator (SS).

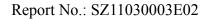
#### (2) USB Test Mode

The EUT configuration of the emission tests is <u>TransFlash Card + EUT + Battery + PC.</u>

In this test mode, the EUT with a TransFlash Card embedded is connected with a PC via a special USB cable supplied by applicant. During the measurement, a communication link was established between the EUT and a System Simulator (SS), simultaneity, the date is transmitting between the PC and the TransFlash Card of the EUT.

#### NOTE:

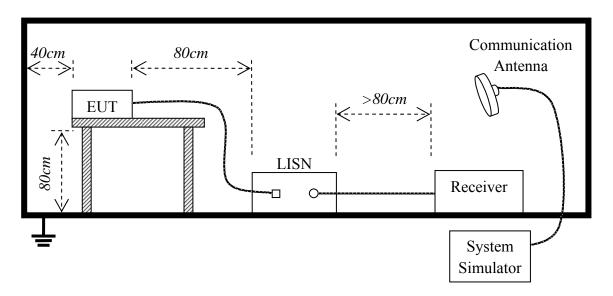
1. All test modes are performed, only the worst cases are recorded in this report.





# 2.1.2 Test Setup

#### 2.1.2.1 Conducted Emission Test

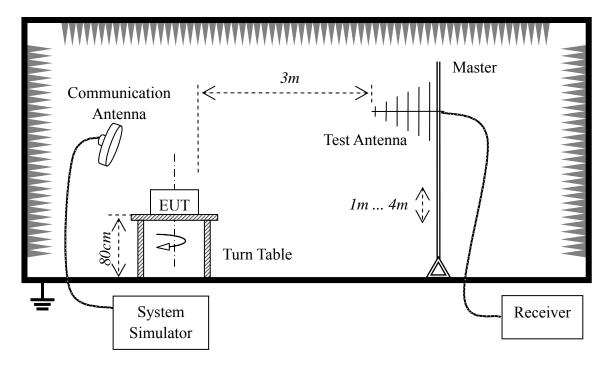


- 1. The test is performed in a Shield Room; the factors of the test system are calibrated to correct the reading.
- 2. The EUT is placed on a 0.8 meters high insulating table and keeps 0.4 meters away from the conducting wall of the Shield Room.
- 3. The EUT is connected to the power mains through a Line Impedance Stabilization Network (LISN). The LISN provides  $50\Omega/50\mu\text{H}$  of coupling impedance for the measuring instrument.





## 2.1.2.2 Radiated Emission Test



- 1. The test is performed in a Semi-anechoic Chamber; the factors of the test system are calibrated to correct the reading.
- 2. The EUT is placed on a 0.8 meters high insulating table and keeps 3 meters away from the trilogy Test Antenna, which is mounted on the top of a variable-height antenna Master tower.

## NOTE:

1. The test method is the substitution method according to TIA-603-C.



## 2.2 Conducted Emission

# 2.2.1 Requirement

According to FCC §15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a  $50\mu\text{H}/50\Omega$  line impedance stabilization network (LISN).

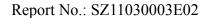
Eraguanay ranga (MUz)	Conducted Limit (dBμV)		
Frequency range (MHz)	Quasi-peak	Average	
0.15 - 0.50	66 to 56	56 to 46	
0.50 - 5	56	46	
5 - 30	60	50	

#### NOTE:

- 1. The limit subjects to the Class B digital device.
- 2. The lower limit shall apply at the band edges.
- 3. The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.50MHz.

#### 2.2.2 Test Procedure

- 1. Perform test setup as described in section 2.1.2.1.
- 2. Each test mode in section 2.1.1 should be applied. At each test mode, the frequency range from 150 kHz to 30MHz is searched using the CISPR Quasi-Peak and/or the Average detector of the Receiver. If the emission levels measured with Quasi-Peak detector are lower than the Average Limit, it's not necessary to measure with Average detector.
- 3. The emission levels at both L phase and N phase should be tested.
- 4. Record the test result plot and distinct points.
- 5. In the test report show the worst test data.

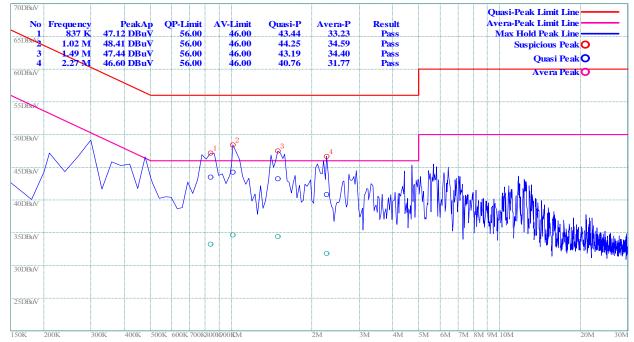




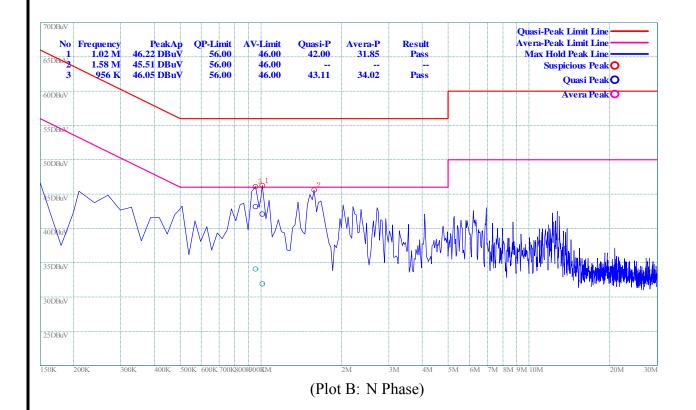
#### 2.2.3 Test Result

## (1) Call Mode

## A. Test Plots and Suspicious Points:



(Plot A: L Phase)

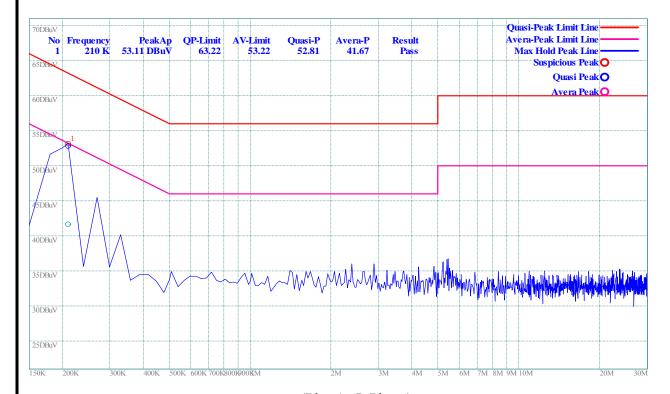




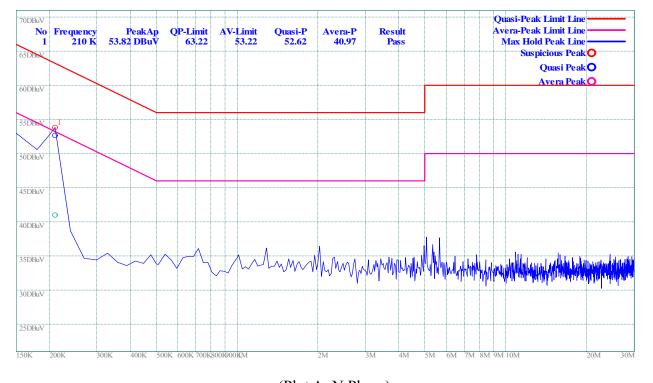


# (2) USB Mode

## A. Test Plots and Suspicious Points:



(Plot A: L Phase)





## 2.3 Radiated Emission

# 2.3.1 Requirement

According to FCC §15.109, the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Eraguanay ranga (MHz)	Field Strength		
Frequency range (MHz)	$\mu V/m$	dBμV/m	
30 - 88	100	40	
88 - 216	150	43.5	
216 - 960	200	46	
Above 960	500	54	

#### NOTE:

- 1. Field Strength  $(dB\mu V/m) = 20*log[Field Strength (\mu V/m)].$
- 2. In the emission tables above, the tighter limit applies at the band edges.

#### 2.3.2 Test Procedure

- 1. Perform test setup as described in section 2.1.2.2.
- 2. Each test mode in section 2.1.1 should be applied. At each test mode, the Turn Table turns from 0 degrees to 360 degrees to find the maximum reading; for the suspected points, the Test Antenna varies from 1 meter to 4 meters to determine the maximum value of the field strength.
- 3. The Receiver is set to Peak Detector function and specified bandwidth with maximum hold mode. If the emission level of the EUT in peak mode is 6dB lower than the limit specified, then testing could be stopped and the peak values would be reported; otherwise the emission less than 6dB margins would be retested one by one using the quasi-peak method.
- 4. The emission levels at both horizontal and vertical polarizations should be tested.
- 5. Record the test result plot and distinct points.
- 6. In the test report show the worst test data.

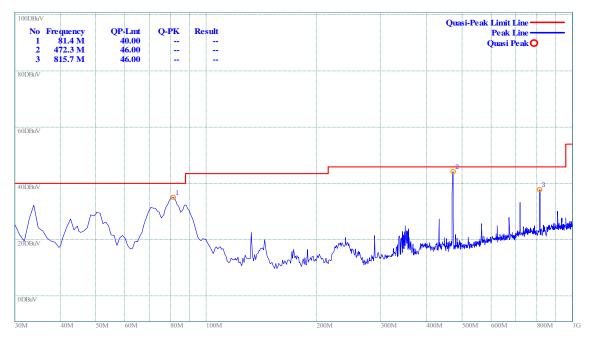


## 2.3.3 Test Result

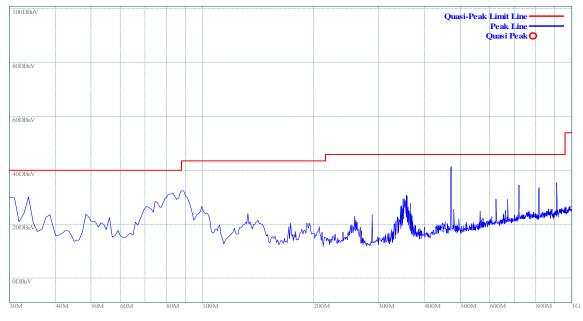
## (1) Call Mode

# A. Test Plots and Suspicious Points:

Following is the plots for emission measurement; please note that marked spikes with circle should be ignored because they are MS and SS carrier frequency.



(Plot A: Test Antenna Vertical)



(Plot B: Test Antenna Horizontal)

